

EMC Test Report

Application No. : HX210301062209

Applicant : Ruian Shuxing Financial Equipment Co., Ltd.

Equipment Under Test (EUT)

EUT Name : Super Micro Bubble Face Cleaner

Model No. : 128A

Serial No. : N/A

Brand Name : N/A

Receipt Date : 2021-03-09

Test Date : 2021-03-09 to 2021-03-12

Issue Date : 2021-03-12

Standards : EN 55014-1: 2017
EN 55014-2: 2015

Conclusions : **PASS**

In the configuration tested, the EUT complied with the standards specified above. The EUT technically complies with the 2014/30/EU directive requirements.

Test/Witness Engineer : *Tim Chen*

Approved & Authorized



This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

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1. General Information

1.1. Client Information

Applicant	:	Ruian Shuxing Financial Equipment Co., Ltd.
Address	:	No.18, North Post and Telecom Road, Linyang Industrial Zone, Nanbin Street, Ruian
Manufacturer	:	Ruian Shuxing Financial Equipment Co., Ltd.
Address	:	No.18, North Post and Telecom Road, Linyang Industrial Zone, Nanbin Street, Ruian

1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Super Micro Bubble Face Cleaner
Model No.	:	128A
Serial No.	:	N/A
Brand Name	:	N/A
Power Supply	:	DC 5V, 1A

Remark: All above models are identical in schematic, structure and critical components except for only different appearance; therefore, EMC testing was performed with 128A only.

1.3. Block Diagram Showing the Configuration of System Tested



1.4. Description of Support Units

The EUT has been tested as an independent unit.

1.5. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

1.6. Classification of Apparatus

Category I: Apparatus containing no electronic control circuitry.

Category II: Transformer toys, dual supply toys, mains powered motor operated appliances, tools, heating appliances and similar electric apparatus (for example-UV radiators, IR radiators and microwave ovens) containing electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

Category III: Battery powered apparatus (with built-in batteries or external batteries), which in normal use is not connected to the mains, containing an electronic control circuitry with no internal clock frequency or oscillator frequency higher than 15MHz.

This category includes apparatus provided with rechargeable batteries which can be charged by connecting the apparatus to the mains power. However, this apparatus shall also be tested as an apparatus in category III while it is connected to the mains network.

Category IV: All other apparatus covered by the scope of this standard.

1.7. Test Facility

The testing report were performed by the The testing report were performed by the Shenzhen HX Detect Certification Co., Ltd., in their facilities located at 2/F, bostai, building 22, Tangxi Yongli Industrial Zone, guxing community, Xixiang street, Bao'an District, Shenzhen.

2. Test Results Summary

EMISSION		
Description of test items	Standards	Results
Conducted disturbance at mains terminals	EN 55014-1: 2017	N/A
Disturbance Power	EN 55014-1: 2017	N/A
Click measurement	EN 55014-1: 2017	N/A
Radiated disturbance	EN 55014-1: 2017	Pass
Harmonic current emissions	EN61000-3-2: 2019	N/A
Voltage fluctuation and flicker	EN61000-3-3:2013/A1:2019	N/A
IMMUNITY		
Description of test items	Basic Standards	Results
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass
Radio-frequency, Continuous Radiated Disturbance	EN 61000-4-3: 2006/A2: 2010	Pass
EFT/B Immunity	EN 61000-4-4: 2012	N/A
Surge Immunity	EN 61000-4-5: 2014/A1:2017	N/A
Conducted RF Immunity	EN 61000-4-6: 2014	N/A
Voltage dips, 40% reduction	EN 61000-4-11:2004/A1:2017	N/A
Voltage dips, 70% reduction		
Voltage interruptions		
Note: N/A is an abbreviation for Not Applicable.		

3. Test Equipment Used

3.1. Test Equipment Used to Measure Conducted Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan. 04, 2021	1 Year
HX-EMC002	AMN	Rohde & Schwarz	ENV216	Jan. 04, 2021	1 Year
HX-EMC003	AMN	SCHWARZBECK	NNBL 8226	Jan. 04, 2021	1 Year
3.2. Test Equipment Used to Measure Disturbance Power					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC001	EMI Test Receiver	Rohde & Schwarz	ESCS30	Jan. 04, 2021	1 Year
HX-EMC028	Power Clamp	Luthi	MDS-21	Jan. 04, 2021	1 Year
3.3. Test Equipment UseTest Equipment Used to Measure Radiated Emission					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC004	EMI Test Receiver	Rohde & Schwarz	ESI26	Jan. 04, 2021	1 Year
HX-EMC005	Bilog Antenna	SCHWARZBECK	VULB9163	Jan. 04, 2021	1 Year
HX-EMC006	Positioning Controller	C&C	CC-C-1F	N/A	N/A
3.4. Test Equipment Used to Measure Harmonic Current/ Voltage Fluctuation and Flicker					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC007	Harmonic Flicker Test System	CI	5001ix-CTS-40	Jan. 04, 2021	1 Year
3.5. Test Equipment Used to Measure Electrostatic Discharge Immunity					
No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC008	ESD Tester	TESEQ	NSG437	Jan. 04, 2021	1 Year
3.6. Test Equipment Used to Measure Conducted Immunity					
HX-EMC009	RF Generator	FRANKONIA	CIT-10/75	Jan. 04, 2021	1 Year
HX-EMC010	Attenuator	FRANKONIA	59-6-33	Jan. 04, 2021	1 Year
HX-EMC011	M-CDN	LUTHI	M2/M3	Jan. 04, 2021	1 Year
HX-EMC012	CDN	LUTHI	AF2	Jan. 04, 2021	1 Year
HX-EMC013	EM Injection Clamp	LUTHI	EM101	Jan. 04, 2021	1 Year

3.7. Test Equipment Used to Measure Radio Frequency Electromagnetic Fields Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC014	Signal Generator	Rohde & Schwarz	SMT03	Jan. 04, 2021	1 Year
HX-EMC015	Power Meter	Rohde & Schwarz	NRVD	Jan. 04, 2021	1 Year
HX-EMC016	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan. 04, 2021	1 Year
HX-EMC017	Voltage Probe	Rohde & Schwarz	URV5-Z2	Jan. 04, 2021	1 Year
HX-EMC018	Power Amplifier	AR	150W1000	Jan. 04, 2021	1 Year
HX-EMC019	Bilog Antenna	Chase	CBL6111C	Jan. 04, 2021	1 Year

3.8. Test Equipment Used to Measure Electrical Fast Transient/Burst Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC020	Simulator	EMTEST	UCS500N5	Jan. 04, 2021	1 Year
HX-EMC021	Auto-transformer	EMTEST	V4780S2	Jan. 04, 2021	1 Year

3.9. Test Equipment Used to Measure Surge Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan. 04, 2021	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan. 04, 2021	1 Year

3.10. Test Equipment Used to Measure Voltage Dips and Interruptions Immunity

No.	Equipment	Manufacturer	Model No.	Last Cal.	Cal. Interval
HX-EMC022	Simulator	EMTEST	UCS500N5	Jan. 04, 2021	1 Year
HX-EMC023	Coupling Clamp	EMTEST	HFK	Jan. 04, 2021	1 Year

4. Conducted Emission Test

4.1. Test Standard and Limit

4.1.1. Test Standard

EN 55014-1: 2017.

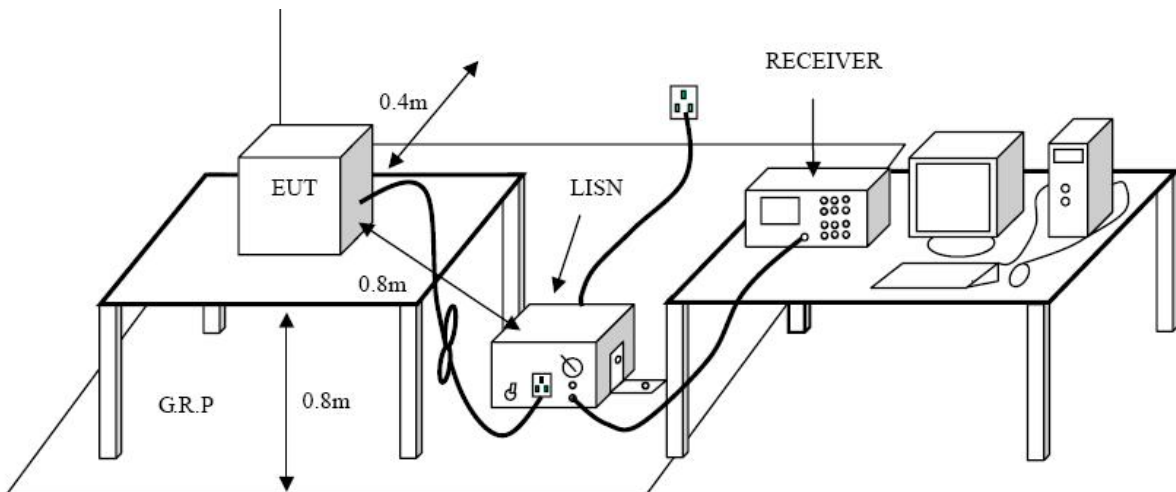
4.1.2. Test Limit

Conducted Disturbance Test Limit

Frequency	Maximum RF Line Voltage (dB μ V)	
	Quasi-peak Level	Average Level
150kHz~350kHz	66 ~ 56*	56 ~ 46 *
350kHz~5MHz	56	46
5MHz~30MHz	60	50

Remark: "*" Decreasing linearly with logarithm of the frequency

4.2. Test Setup



4.3. Test Procedure

The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.

Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.

I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.

LISN at least 80 cm from nearest part of EUT chassis.

The bandwidth of EMI test receiver is set at 9kHz, and the test frequency band is from 0.15MHz to 30MHz.

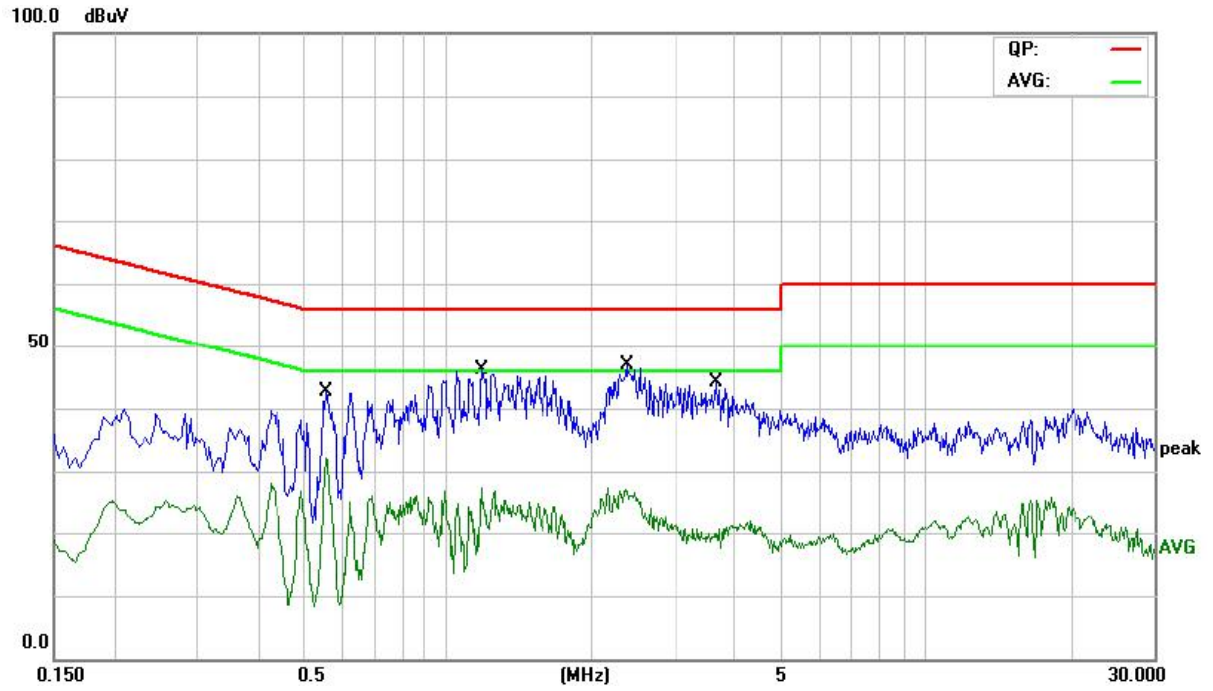
4.4. Test Condition

Temperature	:	25 °C
Relative Humidity	:	48 %
Pressure	:	1010 hPa
Test Power	:	DC 5V

4.5. Test Data

Please refer to the following pages.

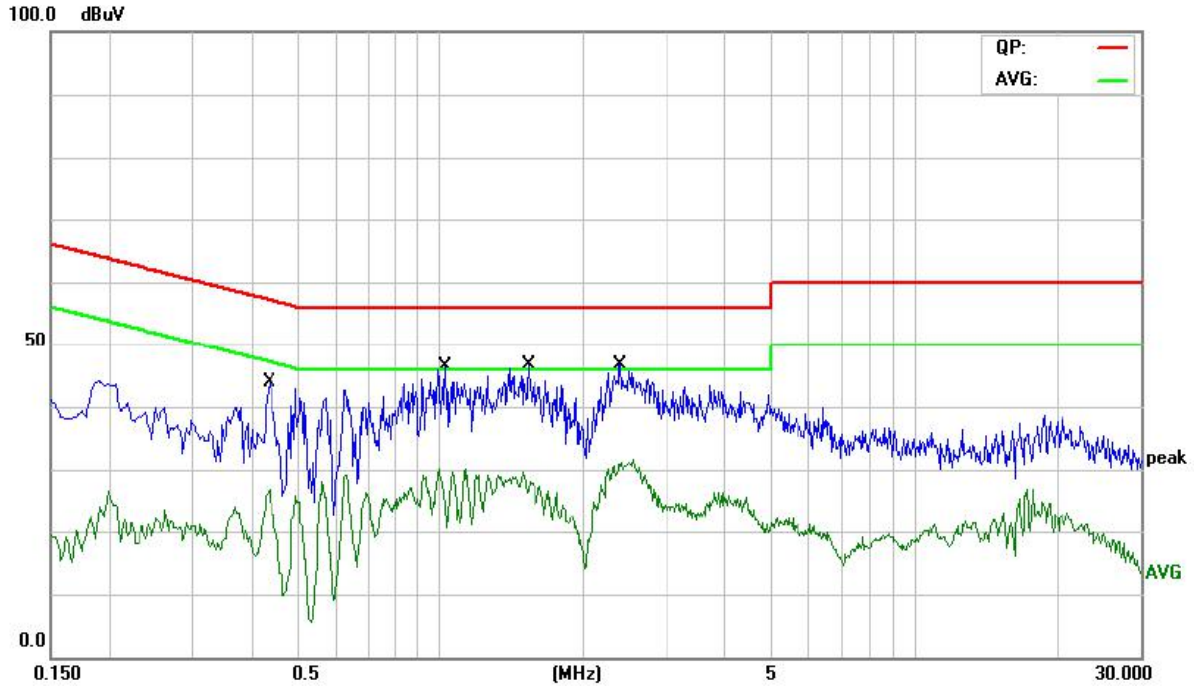
Operating Condition: Normal
Test Specification: L



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.5540	19.75	9.46	29.21	46.00	-16.79	AVG	
2		0.5580	33.09	9.45	42.54	56.00	-13.46	QP	
3		1.1780	36.83	9.34	46.17	56.00	-9.83	QP	
4		1.1820	15.45	9.34	24.79	46.00	-21.21	AVG	
5	*	2.3620	37.57	9.38	46.95	56.00	-9.05	QP	
6		2.3820	17.38	9.38	26.76	46.00	-19.24	AVG	
7		3.6420	34.62	9.44	44.06	56.00	-11.94	QP	
8		3.6420	10.34	9.44	19.78	46.00	-26.22	AVG	

Operating Condition: Normal

Test Specification: N



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector	Comment
1		0.4340	34.37	9.60	43.97	57.18	-13.21	QP	
2		0.4351	16.39	9.59	25.98	47.15	-21.17	AVG	
3		1.0220	36.94	9.33	46.27	56.00	-9.73	QP	
4		1.0220	15.89	9.33	25.22	46.00	-20.78	AVG	
5		1.5339	37.20	9.35	46.55	56.00	-9.45	QP	
6		1.5339	17.20	9.35	26.55	46.00	-19.45	AVG	
7	*	2.3940	37.26	9.38	46.64	56.00	-9.36	QP	
8		2.3940	21.18	9.38	30.56	46.00	-15.44	AVG	

5. Radiated Emission Test

5.1. Test Standard and Limit

5.1.1. Test Standard

EN 55014-1: 2017.

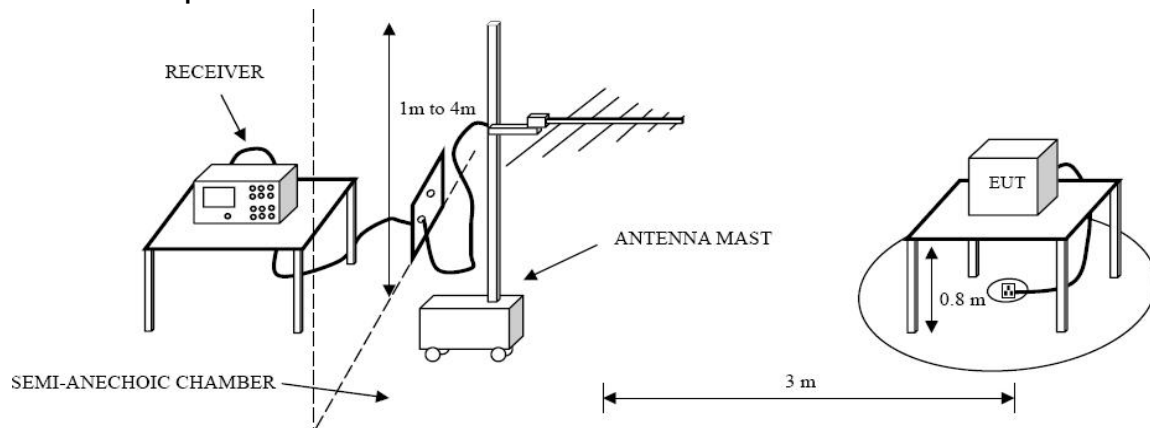
5.1.2. Test Limit

Radiated Disturbance Test Limit

Frequency	Limit (dB μ V/m)
	Quasi-peak Level
30MHz~230MHz	40
230MHz~1000MHz	47

Remark: 1. The lower limit shall apply at the transition frequency.
2. The test distance is 3m.

5.2. Test Setup



5.3. Test Procedure

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation.

The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

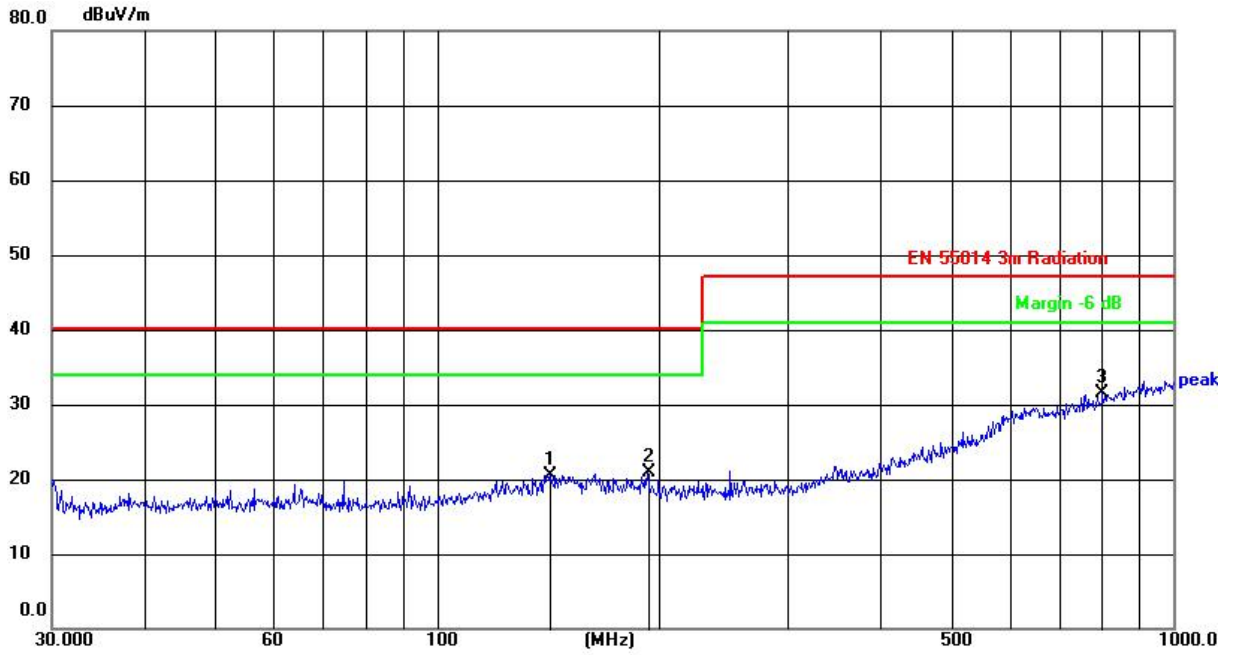
5.4. Test Condition

Temperature	:	23 °C
Relative Humidity	:	52 %
Pressure	:	1010 hPa
Test Power	:	DC 5V

5.5. Test Data

Please refer to the following pages.

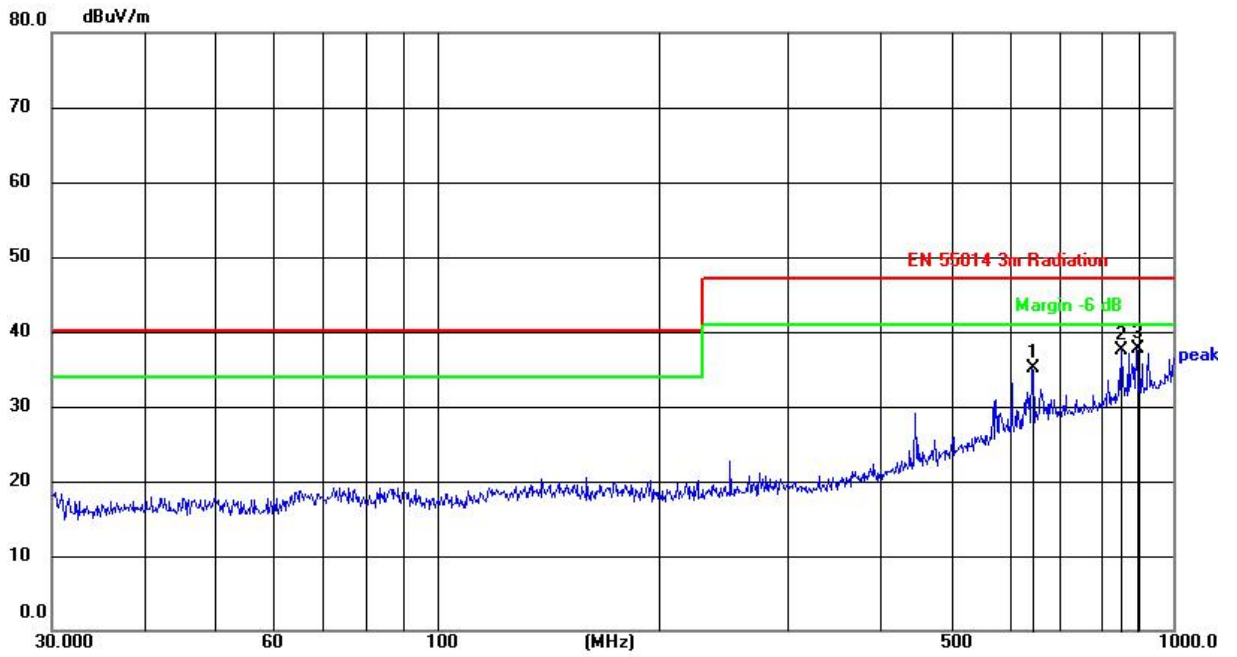
Operating Condition: Normal
Test Specification: Horizontal



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	142.8243	39.31	-18.73	20.58	40.00	-19.42	peak				
2	193.0945	39.11	-18.14	20.97	40.00	-19.03	peak				
3	801.7863	38.90	-7.42	31.48	47.00	-15.52	peak				

Operating Condition: Normal

Test Specification: Vertical



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	642.8613	45.17	-10.12	35.05	47.00	-11.95	peak				
2	851.0353	44.24	-6.68	37.56	47.00	-9.44	peak				
3	890.7278	43.72	-6.05	37.67	47.00	-9.33	peak				

6. Electrostatic Discharge Immunity Test

6.1. Test Requirements

6.1.1. Test Standard

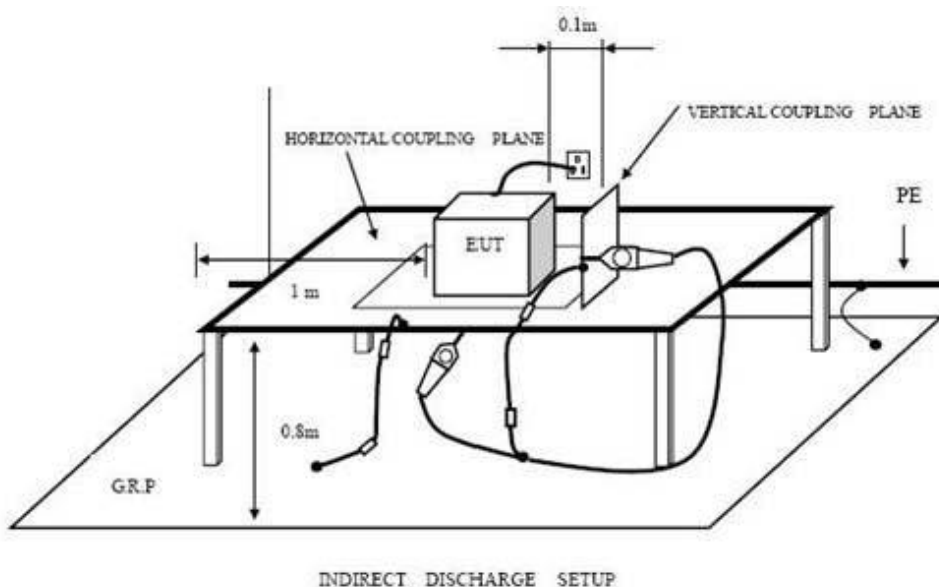
EN 55014-2: 2015 (EN 61000-4-2:2009)

6.1.2. Test Level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.0	±2	±2
2.0	±4	±4
3.0	±6	±8
4.0	±8	±15
X	Special	Special

6.1.3. Performance criterion: B

6.2. Test Setup



6.3. Test Procedure

6.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

6.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

6.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

6.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

6.4. Test Data

Please refer to the following page.

Electrostatic Discharge Test Result

EUT	: Super Micro Bubble Face Cleaner	M/N	: 128A
Temperature	: 22°C	Humidity	: 50%
Power supply	: DC 5V	Test Mode	: Normal
Criterion: B			
Air Discharge: ±8kV Contact Discharge: ±4kV			
For each point positive 10 times and negative 10 times discharge.			
Location	Kind A-Air Discharge C-Contact Discharge		Result
Nonconductive Enclosure	A		PASS
Button	A		PASS
Conductive Enclosure	C		PASS
HCP	C		PASS
VCP of front	C		PASS
VCP of rear	C		PASS
VCP of left	C		PASS
VCP of right	C		PASS
Remark:			

7. Radiated Electromagnetic Field Immunity test

7.1. Test Requirements

7.1.1. Test Standard

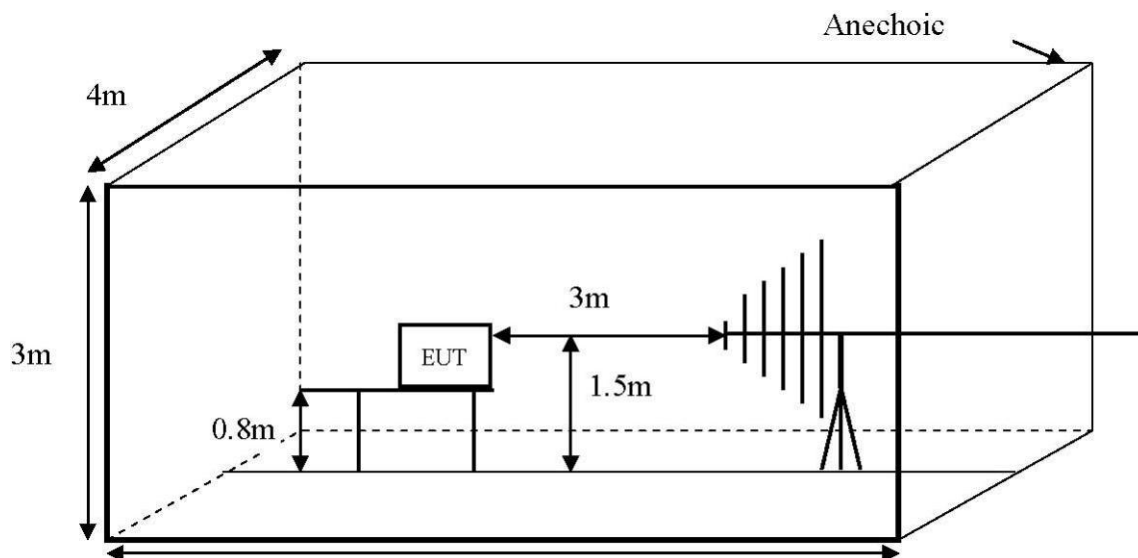
EN55014-2: 2015 (EN 61000-4-3: 2006 + A1: 2008 + A2:2010)

7.1.2. Test Level

Level	Field Strength V/m
1.0	1
2.0	3
3.0	10
X	Special

7.1.3. Performance criterion: A

7.2. Test Setup



7.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
1. Fielded Strength	3V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80-1000MHz
4. Sweep time of radiated	0.0015 Decade/s
5. Dwell Time	1 Sec.

7.4. Test Data

Please refer to the following page.

RF Field Strength Susceptibility Test Results

EUT	: Super Micro Bubble Face Cleaner	M/N	: 128A	
Temperature	: 22°C	Humidity	: 50%	
Power supply	: DC 5V	Test Mode	: Normal	
Criterion: A				
Modulation: Unmodulated				
Pulse: AM 1KHz 80%				
	Frequency Range 1		Frequency Range 2	
	80~1000MHz		/	
	Horizontal	Vertical	Horizontal	Vertical
Front	PASS	PASS	/	/
Right	PASS	PASS	/	/
Rear	PASS	PASS	/	/
Left	PASS	PASS	/	/

8. Photographs - Constructional Details

Photo 1 Test Setup



Photo 2 Appearance of EUT



Photo 3 Appearance of EUT



Photo 4 Appearance of EUT



Photo 5 Appearance of EUT

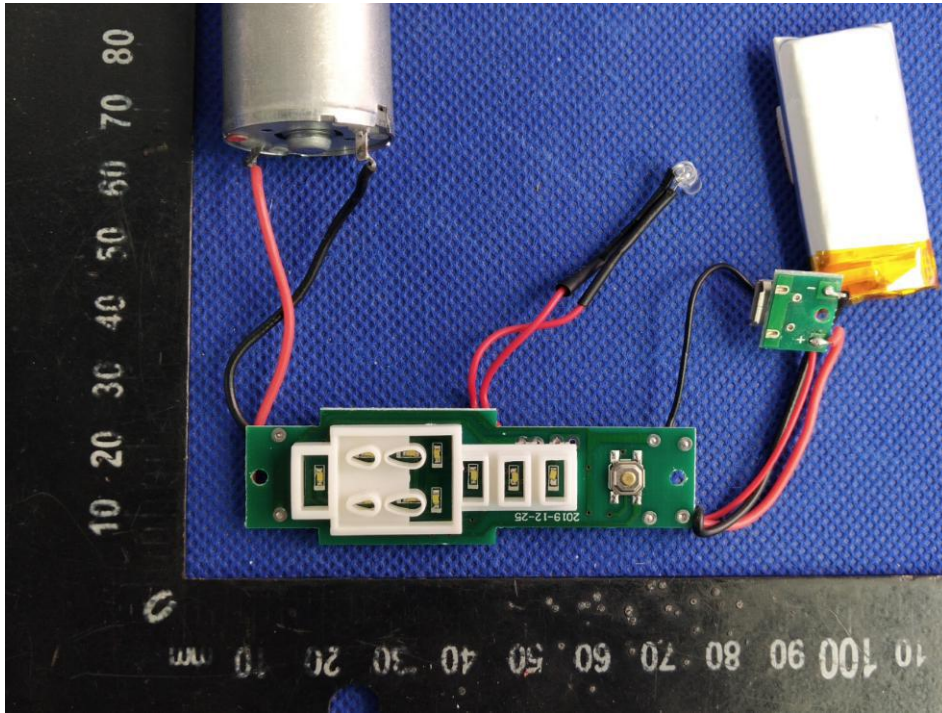
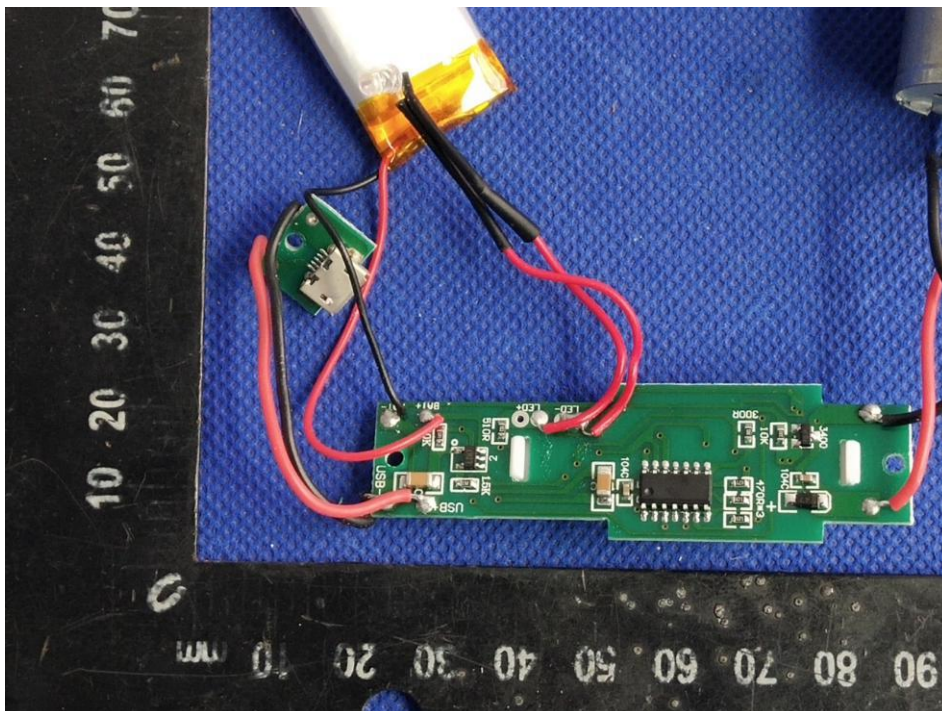


Photo 6 Appearance of EUT



END OF REPORT

Test Report

Applicant : Ruian Shuxing Financial Equipment Co., Ltd.
Address : No.18, North Post and Telecom Road, Linyang Industrial Zone, Nanbin Street, Ruian
Manufacturer : Ruian Shuxing Financial Equipment Co., Ltd.
Address : No.18, North Post and Telecom Road, Linyang Industrial Zone, Nanbin Street, Ruian

The submitted sample and sample information was/were submitted and identified by/on the behalf of the client

Sample name : Super Micro Bubble Face Cleaner
Sample Model : 128A
Trademark : N/A

TEST INFORMATION

Date of Receipt : 2021-04-15
Date of Test : 2021-04-15 to 2021-04-21
Test Method : Please refer to the following page(s).
Test Result(s) : Please refer to the following page(s).

Test Requested	Conclusion
As specified by client, according to RoHS Directive 2011/65/EU with amendment (EU) 2015/863 to test Lead (Pb), Cadmium (Cd), Mercury(Hg), Hexavalent Chromium(Cr(VI)), Polybrominated Biphenyls(PBBs), Polybrominated Diphenyl Ethers(PBDEs), Phthalates(DBP, BBP, DEHP, DIBP) in the submitted sample(s)	Pass

Test/Witness Engineer :

:



Approved & Authorized :

:

Andy Zhang



Tested Sample/Part Description

No.	Component Description(non-metallic)	No.	Component Description(metal)
1	Shell	12	Screw
2	Switch Button	13	USB Interface
3	PCB	14	Solder
4	Straw	15	Electric machinery
5	Soft rubber sucker		
6	Hard rubber sucker		
7	Wire		
8	Li-Polymer Battery		
9	Water tank		
10	Lamp beads		
11	Capacitance		

Test Result of XRF
(1)XRF

Tested Item(s)	Result														
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
Lead (Pb)	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL
Cadmium (Cd)	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL
Mercury (Hg)	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL
Total Chromium (Cr)	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL
Total Bromine (Br)	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	BL	/	/	/	/

(1) Test Method

Tested Item(s)	Test Method	Test instrument
Lead (Pb) Cadmium (Cd) Mercury (Hg) Total Chromium (Cr) Total Bromine (Br)	IEC 62321-2:2013, IEC 62321-1:2013, IEC 62321-3-1:2013,	XRF

Remark:

- (a) BL = Below Limit, OL = Over Limit, LOD = Limit of Detection, -- = Not Regulated,
 3σ = The reproducibility of analytical instruments
 X: the region where further investigation is necessary,
 *=The screened result was found by XRF and further chemical test was suggested
- (b) There are the results on total Br while test items on restricted substances are PBBs and PBDEs.
 There is the result on total Cr while test item on restricted substances is Cr(VI).
- (c) Results are obtained by EDXRF for primary screening, and further chemical testing by ICP-OES (for Cd, Pb, Hg), UV-Vis (for Cr(VI)) and GC-MS (for PBBs, PBDEs) is recommended to be performed, if the concentration exceeds the below warning value according to IEC62321 (unit: mg/kg).

Element	Polymer materials	Metallic materials	Composite materials
Cadmium (Cd)	$BL \leq (70-3\delta) < X < (130+3\delta) \leq OL$	$BL \leq (70-3\delta) < X < (130+3\delta) \leq OL$	$LOD < X < (150+3\delta) \leq OL$
Lead (Pb)	$BL \leq (700-3\delta) < X < (1300+3\delta) \leq OL$	$BL \leq (700-3\delta) < X < (1300+3\delta) \leq OL$	$BL \leq (500-3\delta) < X < (1500+3\delta) \leq OL$
Mercury (Hg)	$BL \leq (700-3\delta) < X < (1300+3\delta) \leq OL$	$BL \leq (700-3\delta) < X < (1300+3\delta) \leq OL$	$BL \leq (500-3\delta) < X < (1500+3\delta) \leq OL$
Chromium (Cr)	$BL \leq (700-3\delta) < X$	$BL \leq (700-3\delta) < X$	$BL \leq (500-3\delta) < X$
Bromine (Br)	$BL \leq (300-3\delta) < X$	Not Applicable	$BL \leq (250-3\delta) < X$

RoHS Requirement

Restricted substances	Limits
Lead(Pb)	0.1%(1000 ppm)
Cadmium(Cd)	0.01%(100 ppm)
Mercury(Hg)	0.1%(1000 ppm)
Chromium(VI)(Cr6+)	0.1%(1000 ppm)
Polybrominated biphenyls(PBBs)	0.1%(1000 ppm)
Polybrominated diphenyl ethers (PBDEs)	0.1%(1000 ppm)

The above limits were quoted from 2011/65/EU with amendment (EU) 2015/863.

(2)Chemical Test
(a)The test result of PBBs, PBDEs

Tested Item	Result(mg/kg)										
	1	2	3	4	5	6	7	8	9	10	11
Monobromobiphenyl (MonoBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Dibromobiphenyl (DiBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Tribromobiphenyl (TriBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Tetrabromobiphenyl (TetraBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Pentabromobiphenyl (PentaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Hexabromobiphenyl (HexaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Heptabromobiphenyl (HeptaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Octabromobiphenyl (OctaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Nonabromobiphenyl (NonaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Decabromobiphenyl (DecaBB)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Sum of polybrominated Biphenyls(PBBs)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Monobromodiphenyl ether (MonoBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Dibromodiphenyl ether (DiBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Tribromodiphenyl ether (TriBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Tetrabromodiphenyl ether (TetraBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Pentabromodiphenyl ether (PentaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Hexabromodiphenyl ether (HexaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Heptabromodiphenyl ether (HeptaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Octabromodiphenyl ether (OctaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Nonabromodiphenyl ether (NonaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Decabromodiphenyl ether (DecaBDE)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Sum of polybrominated diphenyl ethers(PBDEs)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.

(b) The test result of DBP, BBP, DEHP, DIBP

Tested Item(s)	Result										
	1	2	3	4	5	6	7	8	9	10	11
Dibutyl phthalate(DBP)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Benzylbutyl phthalate(BBP)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Di-2-ethylhexyl phthalate(DEHP)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.
Diisobutyl phthalate(DIBP)	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.	N.D.

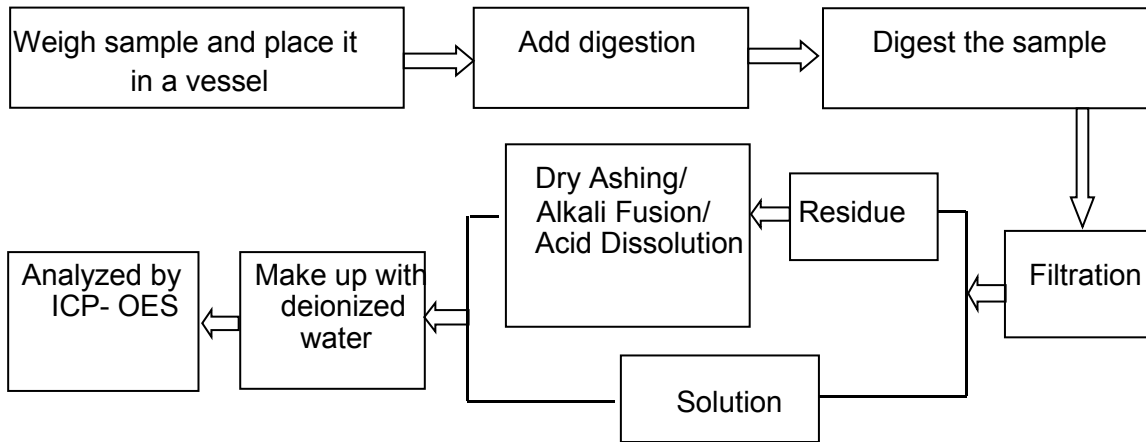
(c) Test Method for Chemical Confirmation

Test Item	Test Method	Test Instrument	MDL (mg/kg)	EU RoHS Limit (mg/kg)
Cadmium (Cd)	IEC 62321-5:2013	ICP-OES	10	100
Lead (Pb)	IEC 62321-5:2013	ICP-OES	10	1000
Mercury (Hg)	IEC 62321-4:2013	ICP-OES	10	1000
Hexavalent Chromium (Cr(VI))	IEC 62321-7-2:2017 (non-metal)	UV-Vis	10	1000
	IEC 62321-7-1:2015 (metal)	UV-Vis	0.1($\mu\text{g}/\text{cm}^2$)	1000
Polybrominated Biphenyls (PBBs)	IEC 62321-6:2015	GC-MS	10	1000
Polybrominated Diphenyl Ethers (PBDEs)	IEC 62321-6:2015	GC-MS	10	1000
Phthalates(DBP, BBP, DEHP, DIBP)	IEC 62321-8:2017	GC-MS	50	1000

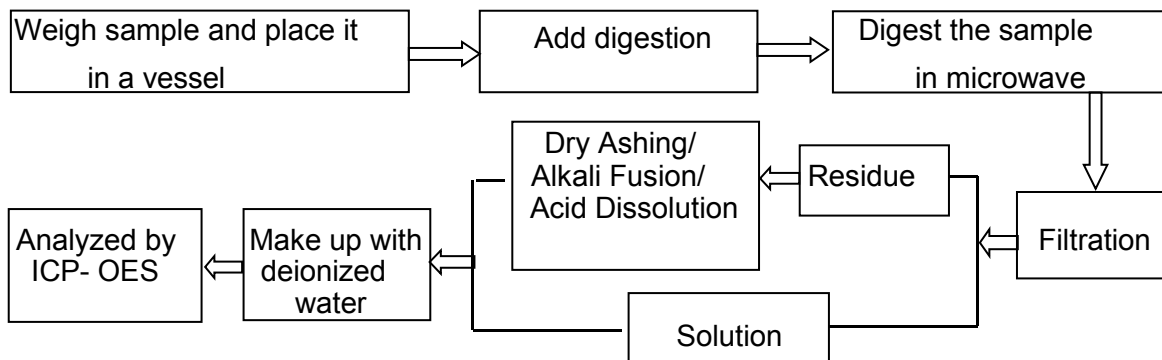
Remark: MDL = Method Detection Limit
 N.D. = Not Detected (<MDL)
 mg/kg = ppm = parts per million

Test Process

1. Lead(Pb), Cadmium(Cd), Chromium(Cr)

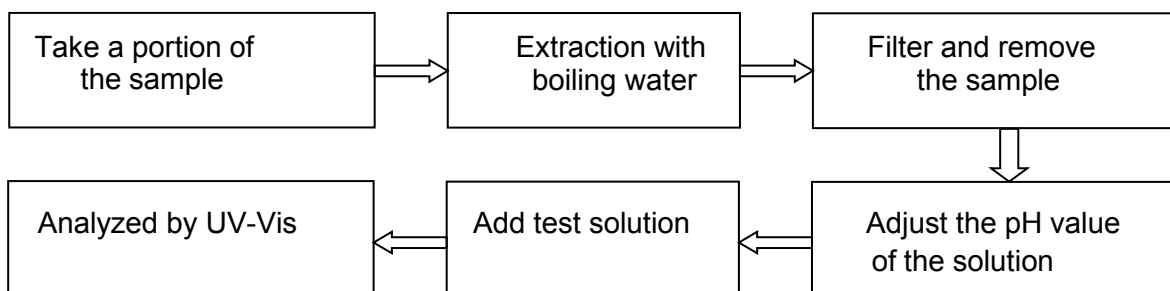


2. Mercury(Hg)



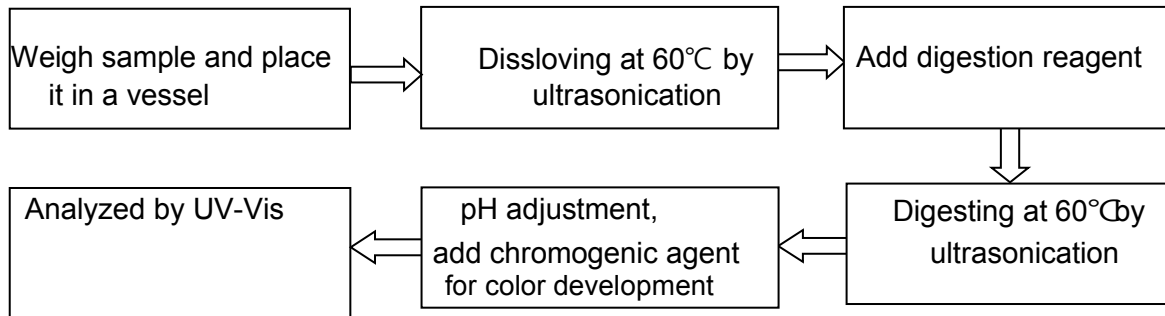
3. Hexavalent Chromium (Cr (VI))

**(1) IEC 62321-7-1:2015
Plating/Metal sample(s)**



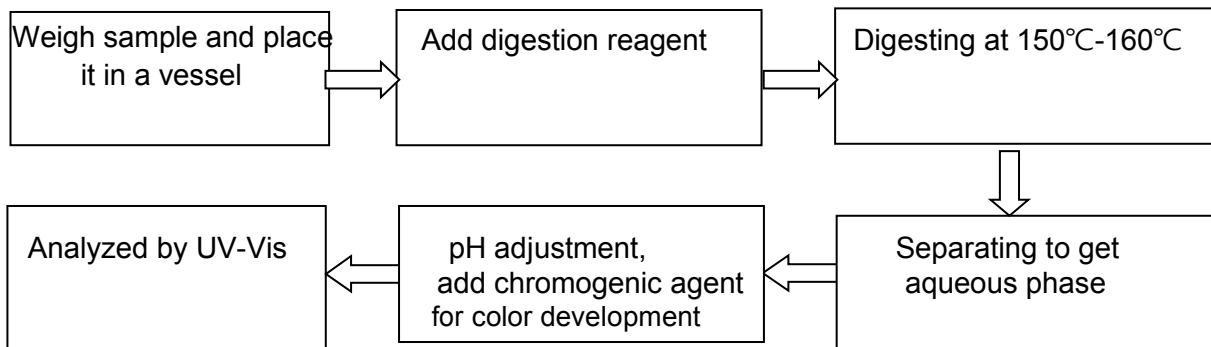
(2) IEC 62321-7-2:2017

Non-metal sample(s) (Material ABS/PC/PVC)

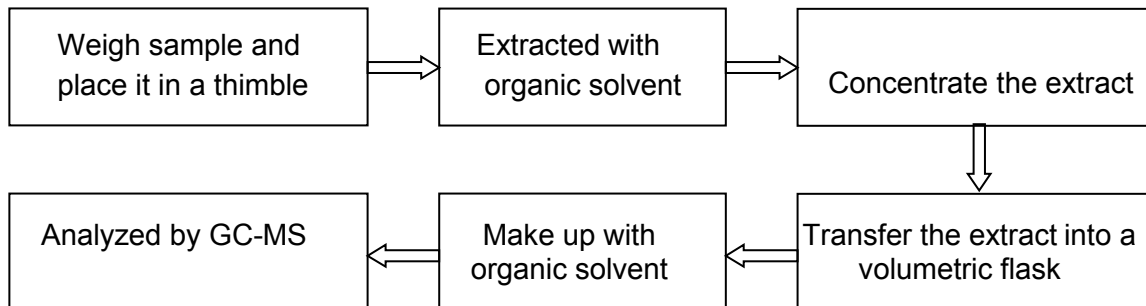


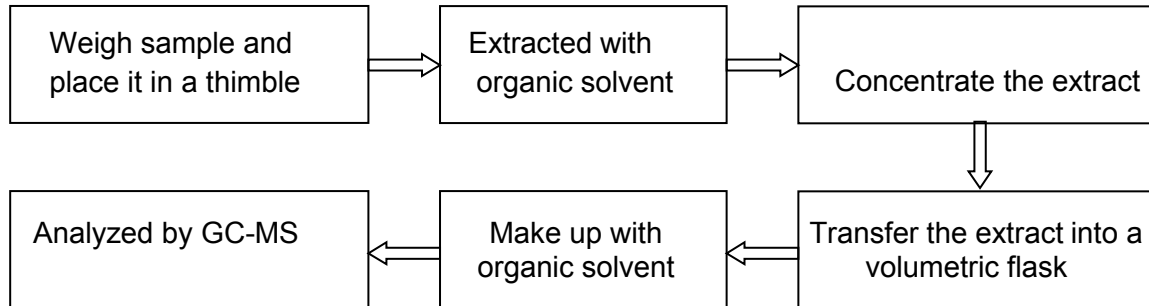
(3) IEC 62321-7-2:2017

Non-metal sample(s) (Others)



4. Polybrominated Biphenyls (PBBs), Polybrominated Diphenyl Ethers (PBDEs)



5. Phthalates(DBP/BBP/DEHP/DIBP)**Remark:**

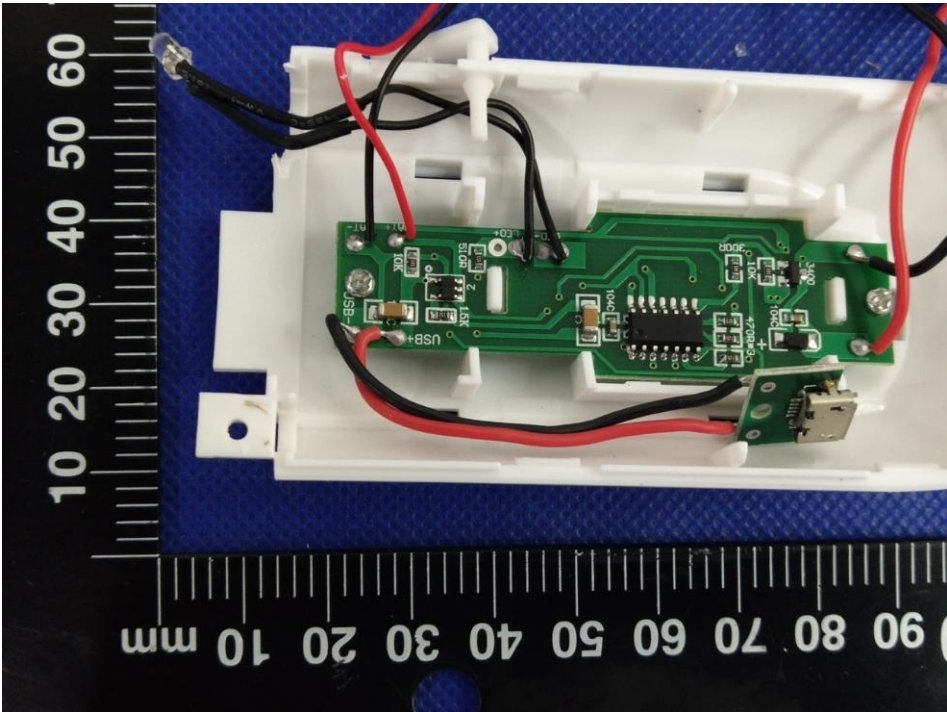
- Chemical confirmation tests were conducted to verify the inconclusive, Chromium (VI) (Cr^{6+}), Polybrominated biphenyls (PBBS) and Polybrominated included in this report.
- As requested by the applicant, only components shown in this report were screened by XFR spectroscopy for 2011/65/EU & (EU) 2015/863, other components were not screened included in this report.

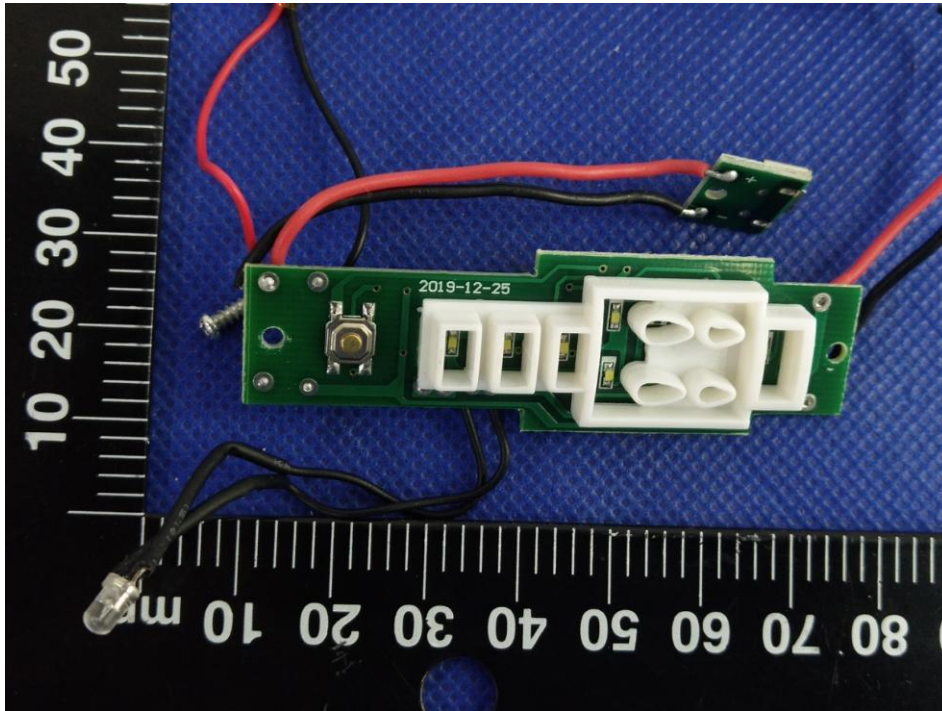
Disclaimers:

- This XRF Screening Report tests were reference purposes only. The applicant shall make its/his/her purposes.
- The results shown in this XRF screening Report will based on various factors. Including but not limited to, the sample size, thickness, area, surface flatness, equipment parameters and matrix effect (e.g. Plastic, Rubber, Metal, Glass, Ceramic etc.). Further wet chemical pre-treatment with relevant chemical equipment analysis are required to obtain quantitative data.
- Photo is included.

Photograph of Sample







***** **End of Report** *****